**AFM Probe Specifications:** 

Coating

**Gold Overall** 

Additional Info

AFM probes of the 160AC series are designed for standard tapping mode AFM imaging in air or vacuum.

The tetrahedral AFM tip is located precisely at the free end of the AFM cantilever. This allows the AFM tip to be positioned accurately over the area of interest on the sample surface.

The gold coated AFM tip is suitable for biological applications, AFM tip functionalization and custom applications. The overall gold coating ensures inertness and electrical conductivity, as well as high and stable laser reflectivity in air, vacuum, liquid and aggressive chemical environments.

## AFM Tip:

Shape	Height	Setback	Radius	Half Cone Angle		
Optimized Positioning	14 μm (12 - 16 μm)*	0 μm	< 30 nm	0° front, 35° back, <9° side		

\* typical values

## **AFM Cantilever:**

Cantilever	Shape	Force Const.	Res. Freq.	Lenght	Width	Thickness
Standard tapping mode AFM cantilever	Beam	<b>26 N/m</b> (8 - 57 N/m)*	300 kHz (200 - 400 kHz)*	<b>160 μm</b> (1 - 170μm)*	<b>40 μm</b> (38 - 42μm)*	<b>4μm</b> (3.5 - 4.5 μm)*

<sup>\*</sup> typical values